## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OOTSUKA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,825,892	10-1998	Braudaway et al.	380/51
*	В	US-2002/0016921	02-2002	Olsen et al.	. 713/200
*	С	US-5,634,012	05-1997	Stefik et al.	705/39
*	D	US-2003/0033529	02-2003	Ratnakar et al.	713/176
*	Ε	US-6,148,333	11-2000	Guedalia et al.	709/219
*	F	US-2001/0008557	07-2001	Stefik et al.	380/202
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			• •
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002342060 A	11-2002	Japan	AKIYOSHI, KATSUMI	
	0					
	Р					
	Q					
	R					
	s					
	ı					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	<b>V</b>	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.